

Electrical Characteristics ($T_J=25^\circ\text{C}$ unless otherwise noted)

| Symbol | Parameter | Conditions | Min | Typ | Max | Units |
|-----------------------------|---------------------------------------|---|------|------------|----------|------------------|
| STATIC PARAMETERS | | | | | | |
| BV_{DSS} | Drain-Source Breakdown Voltage | $I_D=250\mu\text{A}, V_{GS}=0\text{V}$ | 20 | | | V |
| I_{DSS} | Zero Gate Voltage Drain Current | $V_{DS}=20\text{V}, V_{GS}=0\text{V}$ $T_J=55^\circ\text{C}$ | | | 1 5 | μA |
| I_{GSS} | Gate-Body leakage current | $V_{DS}=0\text{V}, V_{GS}=\pm 12\text{V}$ | | | 100 | nA |
| $V_{GS(\text{th})}$ | Gate Threshold Voltage | $V_{DS}=V_{GS}, I_D=250\mu\text{A}$ | 0.5 | 1 | 1.6 | V |
| $I_{D(\text{ON})}$ | On state drain current | $V_{GS}=10\text{V}, V_{DS}=5\text{V}$ | 160 | | | A |
| $R_{DS(\text{ON})}$ | Static Drain-Source On-Resistance | $V_{GS}=4.5\text{V}, I_D=20\text{A}$ $T_J=125^\circ\text{C}$ | | 3.3 4.6 | 4 5.6 | $\text{m}\Omega$ |
| | | $V_{GS}=2.5\text{V}, I_D=20\text{A}$ | | 4.5 | 5.6 | $\text{m}\Omega$ |
| g_{FS} | Forward Transconductance | $V_{DS}=5\text{V}, I_D=20\text{A}$ | | 50 | | S |
| V_{SD} | Diode Forward Voltage | $I_S=1\text{A}, V_{GS}=0\text{V}$ | | 0.7 | 1 | V |
| I_S | Maximum Body-Diode Continuous Current | | | | 45 | A |
| DYNAMIC PARAMETERS | | | | | | |
| C_{iss} | Input Capacitance | $V_{GS}=0\text{V}, V_{DS}=10\text{V}, f=1\text{MHz}$ | 3080 | 3860 | 4630 | pF |
| C_{oss} | Output Capacitance | | 520 | 740 | 960 | pF |
| C_{rss} | Reverse Transfer Capacitance | | 350 | 580 | 810 | pF |
| R_g | Gate resistance | $V_{GS}=0\text{V}, V_{DS}=0\text{V}, f=1\text{MHz}$ | 0.6 | 1.4 | 2.1 | Ω |
| SWITCHING PARAMETERS | | | | | | |
| $Q_g(4.5\text{V})$ | Total Gate Charge | $V_{GS}=10\text{V}, V_{DS}=10\text{V}, I_D=20\text{A}$ | 28 | 36 | 43 | nC |
| Q_{gs} | Gate Source Charge | | 7 | 9 | 11 | nC |
| Q_{gd} | Gate Drain Charge | | 7 | 12 | 17 | nC |
| $t_{D(\text{on})}$ | Turn-On Delay Time | $V_{GS}=10\text{V}, V_{DS}=10\text{V}, R_L=0.5\Omega, R_{\text{GEN}}=3\Omega$ | | 7 | | ns |
| t_r | Turn-On Rise Time | | | 8 | | ns |
| $t_{D(\text{off})}$ | Turn-Off Delay Time | | | 70 | | ns |
| t_f | Turn-Off Fall Time | | | 18 | | ns |
| t_{rr} | Body Diode Reverse Recovery Time | $I_F=20\text{A}, dI/dt=500\text{A}/\mu\text{s}$ | 13 | 17 | 20 | ns |
| Q_{rr} | Body Diode Reverse Recovery Charge | $I_F=20\text{A}, dI/dt=500\text{A}/\mu\text{s}$ | 29 | 36 | 43 | nC |

A. The value of R_{JJA} is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with $T_A=25^\circ\text{C}$. The Power dissipation P_{DSM} is based on R_{JJA} and the maximum allowed junction temperature of 150°C. The value in any given application depends on the user's specific board design, and the maximum temperature of 175°C may be used if the PCB allows it.

B. The power dissipation P_D is based on $T_{J(\text{MAX})}=175^\circ\text{C}$, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Repetitive rating, pulse width limited by junction temperature $T_{J(\text{MAX})}=175^\circ\text{C}$. Ratings are based on low frequency and duty cycles to keep initial $T_J=25^\circ\text{C}$.

D. The R_{JJA} is the sum of the thermal impedance from junction to case R_{JJC} and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300μs pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of $T_{J(\text{MAX})}=175^\circ\text{C}$. The SOA curve provides a single pulse rating.

G. The maximum current rating is package limited.

H. These tests are performed with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with $T_A=25^\circ\text{C}$.

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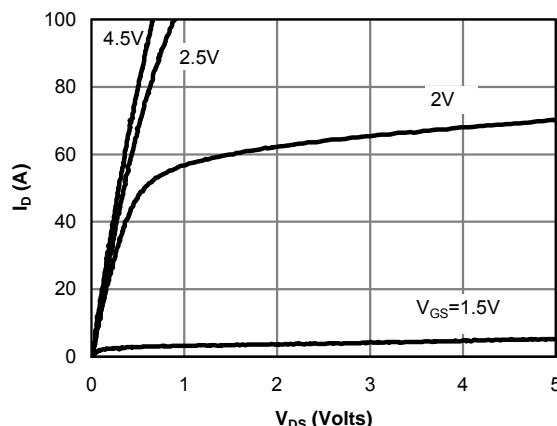
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Fig 1: On-Region Characteristics (Note E)

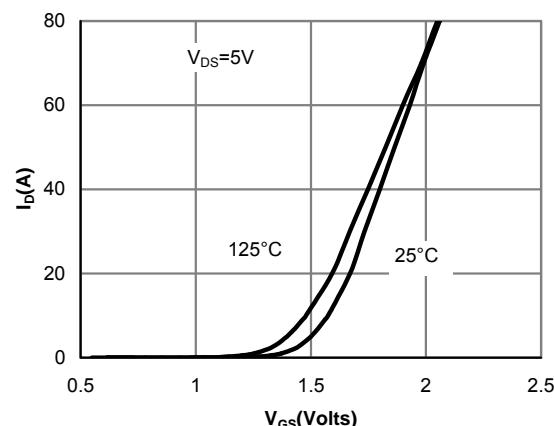


Figure 2: Transfer Characteristics (Note E)

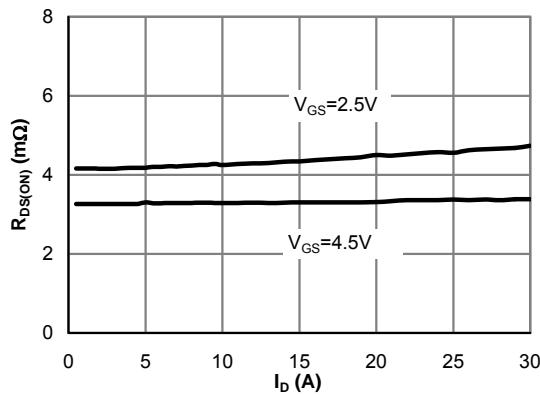


Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)

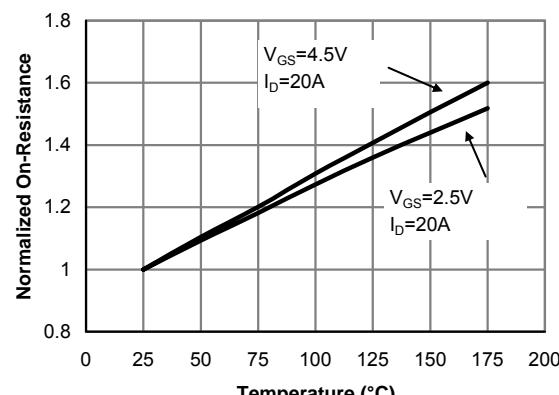


Figure 4: On-Resistance vs. Junction Temperature (Note E)

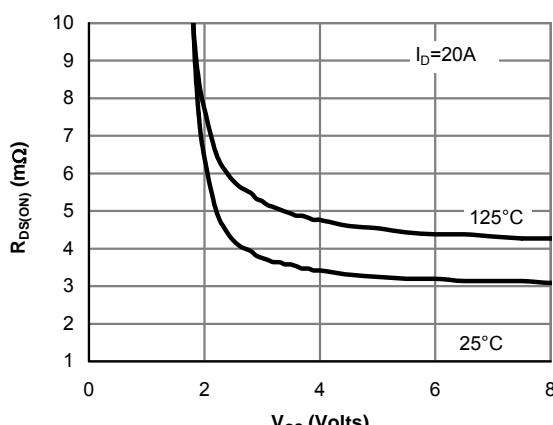


Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)

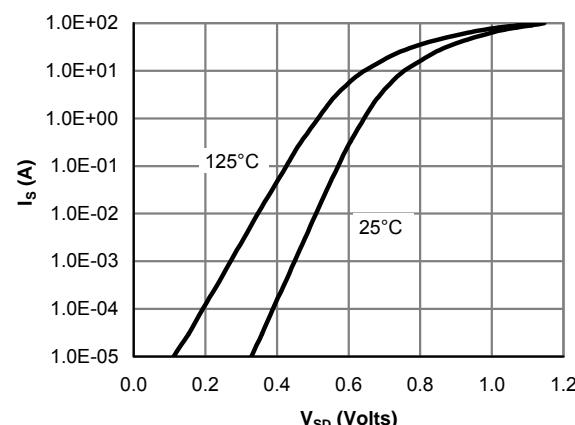
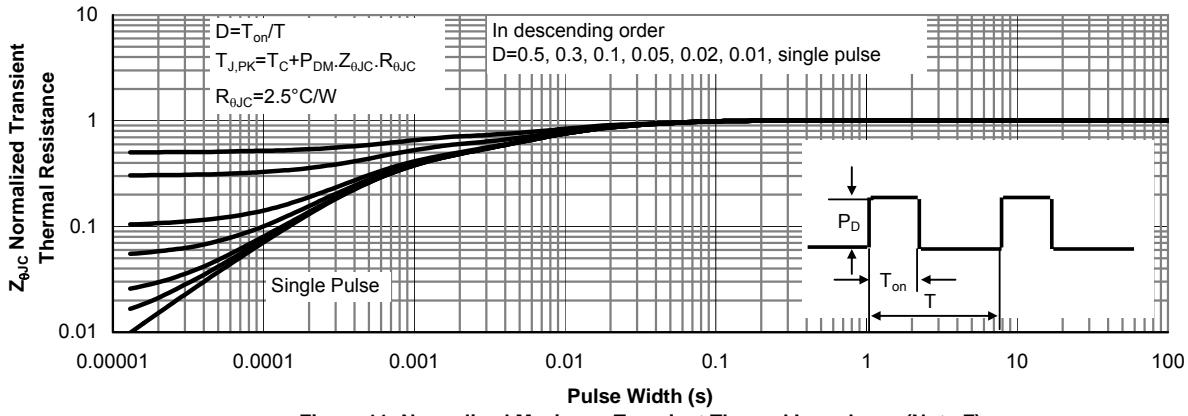
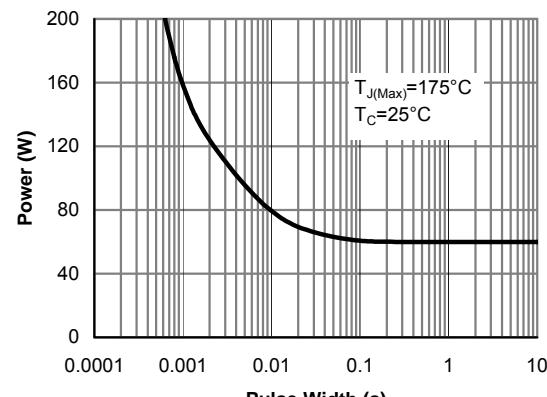
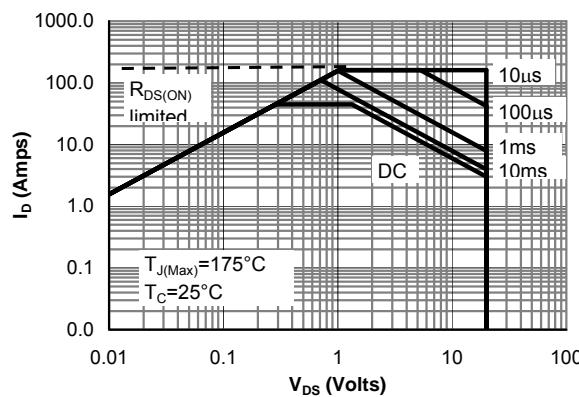
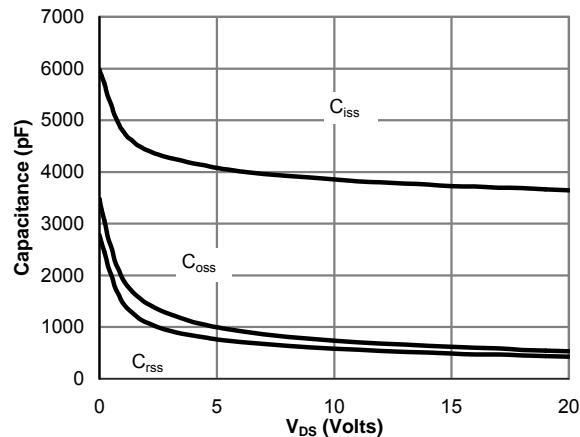
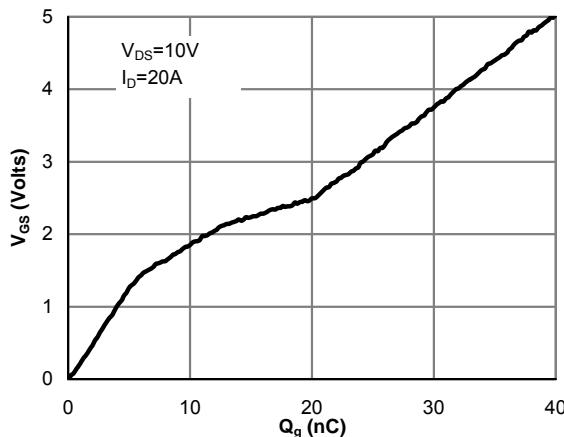
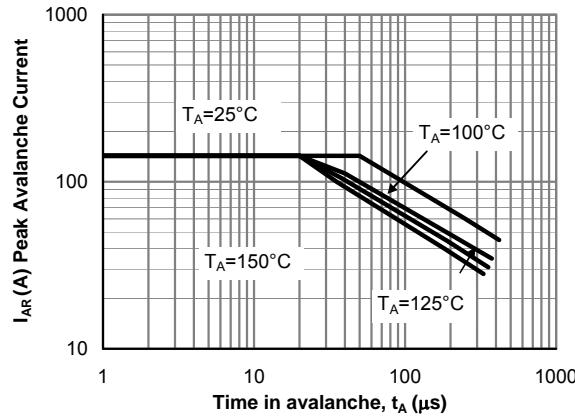
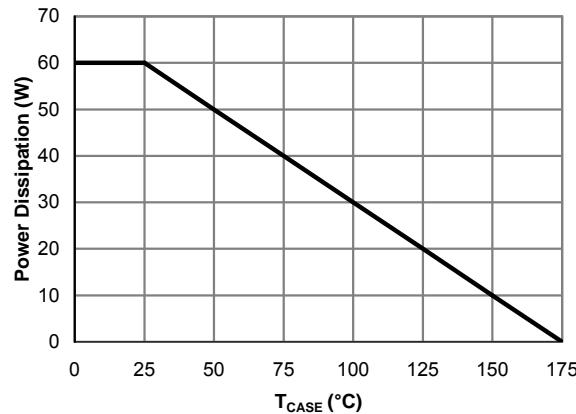
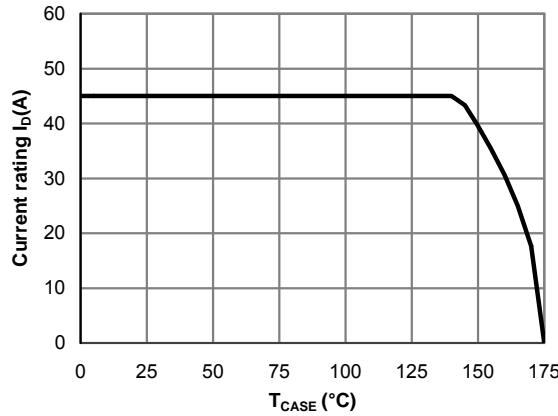
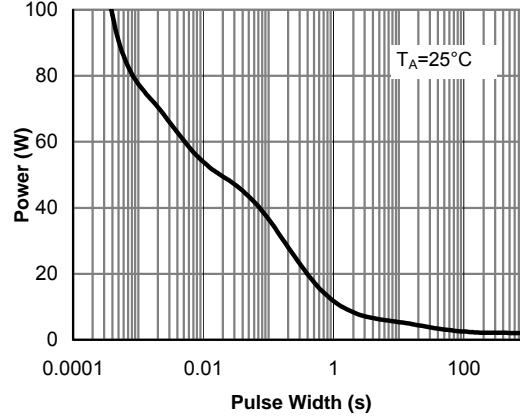
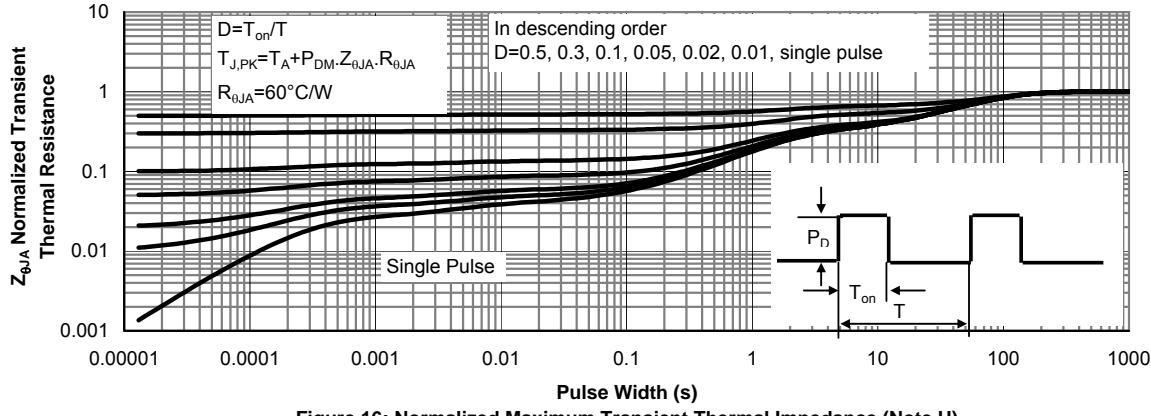
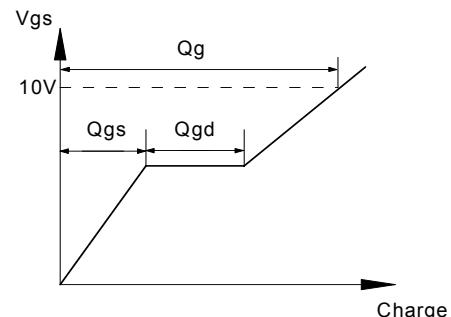
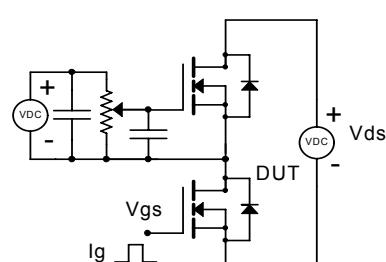
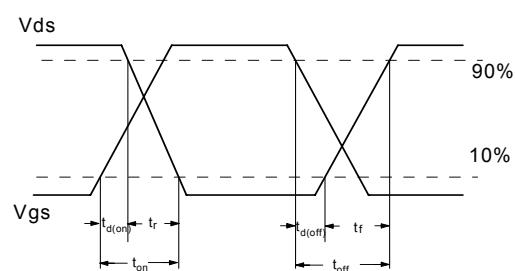
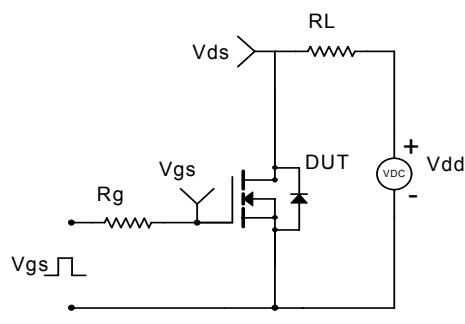
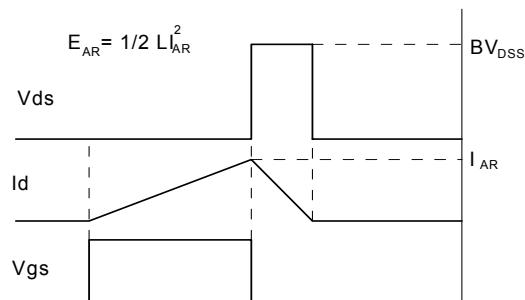
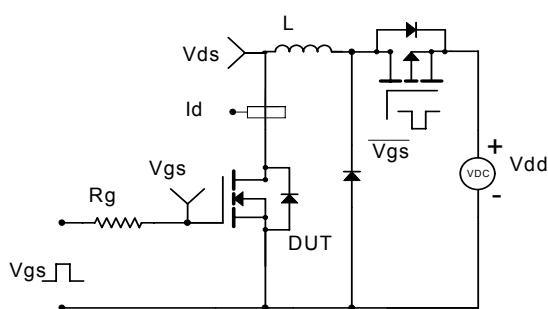


Figure 6: Body-Diode Characteristics (Note E)

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Figure 12: Single Pulse Avalanche capability (Note C)

Figure 13: Power De-rating (Note F)

Figure 14: Current De-rating (Note F)

Figure 15: Single Pulse Power Rating Junction-to-Ambient (Note H)

Figure 16: Normalized Maximum Transient Thermal Impedance (Note H)

Gate Charge Test Circuit & Waveform

Resistive Switching Test Circuit & Waveforms

Unclamped Inductive Switching (UIS) Test Circuit & Waveforms

Diode Recovery Test Circuit & Waveforms
